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March 2015

FDD8424H

Dual N & P-Channel PowerTrench® MOSFET

N-Channel: 40V, 20A, 24mΩ P-Channel: -40V, -20A, 54mΩ

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 24mΩ at V_{GS} = 10V, I_D = 9.0A
- Max $r_{DS(on)}$ = 30mΩ at V_{GS} = 4.5V, I_D = 7.0A

Q2: P-Channel

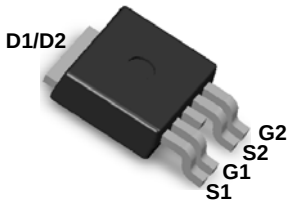
- Max $r_{DS(on)}$ = 54mΩ at V_{GS} = -10V, I_D = -6.5A
- Max $r_{DS(on)}$ = 70mΩ at V_{GS} = -4.5V, I_D = -5.6A
- Fast switching speed
- RoHS Compliant

General Description

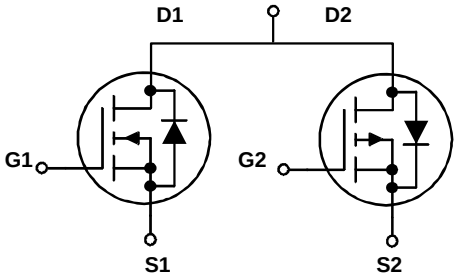
These dual N and P-Channel enhancement mode Power MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench- process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

Application

- Inverter
- H-Bridge



Dual DPAK 4L



N-Channel P-Channel

MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter			Q1	Q2	Units
V_{DS}	Drain to Source Voltage			40	-40	V
V_{GS}	Gate to Source Voltage			±20	±20	V
I_D	Drain Current - Continuous (Package Limited)			20	-20	A
	- Continuous (Silicon Limited)	T_C = 25°C		26	-20	
	- Continuous	T_A = 25°C		9.0	-6.5	
	- Pulsed			55	-40	
P_D	Power Dissipation for Single Operation	T_C = 25°C	(Note 1)	30	35	W
		T_A = 25°C	(Note 1a)	3.1		
		T_A = 25°C	(Note 1b)	1.3		
E_{AS}	Single Pulse Avalanche Energy		(Note 3)	29	33	mJ
T_J, T_{STG}	Operating and Storage Junction Temperature Range			-55 to +150		°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case, Single Operation for Q1 (Note 1)	4.1	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Single Operation for Q2 (Note 1)	3.5	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD8424H	FDD8424H	TO-252-4L	13"	16mm	2500 units

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Electrical Characteristics T_J = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
Off Characteristics							
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = 250μA, V_{GS} = 0V I_D = -250μA, V_{GS} = 0V	Q1 Q2	40 -40			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250μA, referenced to 25°C I_D = -250μA, referenced to 25°C	Q1 Q2		34 -32		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 32V, V_{GS} = 0V V_{DS} = -32V, V_{GS} = 0V	Q1 Q2			1 -1	μA
I_{GSS}	Gate to Source Leakage Current	V_{GS} = ±20V, V_{DS} = 0V	Q1 Q2			±100 ±100	nA nA
On Characteristics							
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 250μA V_{GS} = V_{DS}, I_D = -250μA	Q1 Q2	1 -1	1.7 -1.6	3 -3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250μA, referenced to 25°C I_D = -250μA, referenced to 25°C	Q1 Q2		-5.3 4.8		mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	V_{GS} = 10V, I_D = 9.0A V_{GS} = 4.5V, I_D = 7.0A V_{GS} = 10V, I_D = 9.0A, T_J = 125°C	Q1		19 23 29	24 30 37	mΩ
		V_{GS} = -10V, I_D = -6.5A V_{GS} = -4.5V, I_D = -5.6A V_{GS} = -10V, I_D = -6.5A, T_J = 125°C	Q2		42 58 62	54 70 80	
g_{FS}	Forward Transconductance	V_{DS} = 5V, I_D = 9.0A V_{DS} = -5V, I_D = -6.5A	Q1 Q2		29 13		S
Dynamic Characteristics							
C_{iss}	Input Capacitance	Q1 V_{DS} = 20V, V_{GS} = 0V, f = 1MHZ Q2 V_{DS} = -20V, V_{GS} = 0V, f = 1MHZ	Q1 Q2		750 1000	1000 1330	pF
C_{oss}	Output Capacitance		Q1 Q2		115 140	155 185	pF
C_{rss}	Reverse Transfer Capacitance		Q1 Q2		75 75	115 115	pF
R_g	Gate Resistance	f = 1MHz	Q1 Q2	0.1 0.1	1.1 3.3	3.3 9.9	Ω
Switching Characteristics							
$t_{d(on)}$	Turn-On Delay Time	Q1 V_{DD} = 20V, I_D = 9.0A, V_{GS} = 10V, R_{GEN} = 6Ω Q2 V_{DD} = -20V, I_D = -6.5A, V_{GS} = -10V, R_{GEN} = 6Ω	Q1 Q2		7 7	14 14	ns
t_r	Rise Time		Q1 Q2		13 3	24 10	ns
$t_{d(off)}$	Turn-Off Delay Time		Q1 Q2		17 20	31 36	ns
t_f	Fall Time		Q1 Q2		6 3	12 10	ns
$Q_{g(TOT)}$	Total Gate Charge	Q1 V_{GS} = 10V, V_{DD} = 20V, I_D = 9.0A Q2 V_{GS} = -10V, V_{DD} = -20V, I_D = -6.5A	Q1 Q2		14 17	20 24	nC
Q_{gs}	Gate to Source Charge		Q1 Q2		2.3 3.0		nC
Q_{gd}	Gate to Drain “Miller” Charge		Q1 Q2		3.2 3.6		nC

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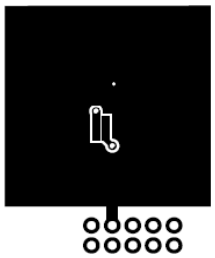
Electrical Characteristics T_J = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
Drain-Source Diode Characteristics							
I_S	Maximum Continuous Drain to Source Diode Forward Current		Q1 Q2			20 -20	A
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current	(Note 2)	Q1 Q2			55 -40	A
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0V, I_S = 9.0A (Note 2) V_{GS} = 0V, I_S = -6.5A (Note 2)	Q1 Q2		0.87 0.88	1.2 -1.2	V
t_{rr}	Reverse Recovery Time	Q1 I_F = 9.0A, di/dt = 100A/s	Q1 Q2		25 29	38 44	ns
Q_{rr}	Reverse Recovery Charge	Q2 I_F = -6.5A, di/dt = 100A/s	Q1 Q2		19 29	29 44	nC

Notes:

1. $R_{\theta JA}$ is determined with the device mounted on a 1in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

Q1

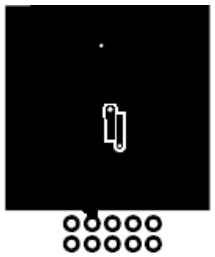


a. 40°C/W when mounted on a 1 in^2 pad of 2 oz copper

Scale 1 : 1 on letter size paper

b. 96°C/W when mounted on a minimum pad of 2 oz copper

Q2



a. 40°C/W when mounted on a 1 in^2 pad of 2 oz copper

Scale 1 : 1 on letter size paper

b. 96°C/W when mounted on a minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300μs, Duty cycle < 2.0%.

3. Starting T_J = 25°C, N-ch: L = 0.3mH, I_{AS} = 14A, V_{DD} = 40V, V_{GS} = 10V; P-ch: L = 0.3mH, I_{AS} = -15A, V_{DD} = -40V, V_{GS} = -10V.

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Typical Characteristics (Q1 N-Channel) T_J = 25°C unless otherwise noted

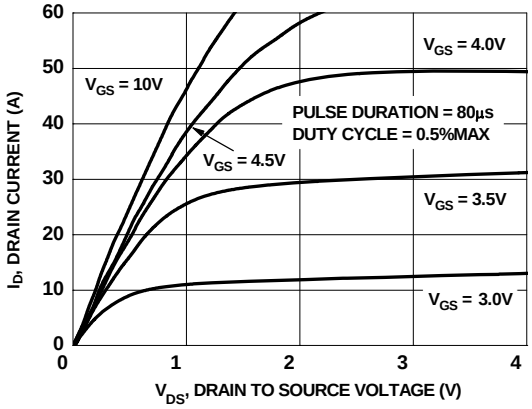


Figure 1. On- Region Characteristics

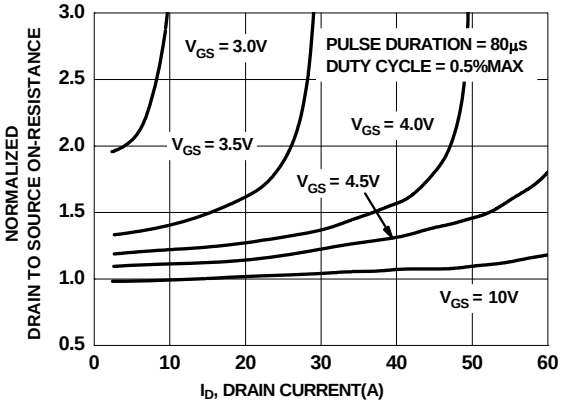


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

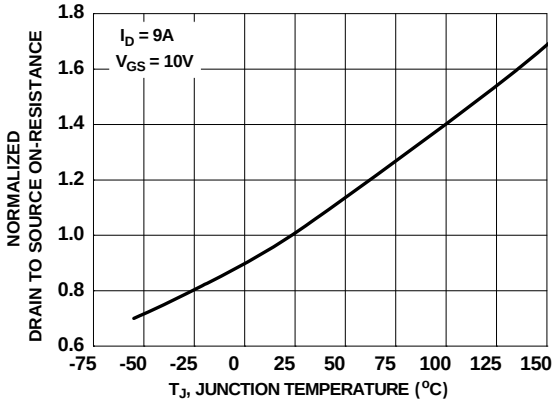


Figure 3. Normalized On-Resistance vs Junction Temperature

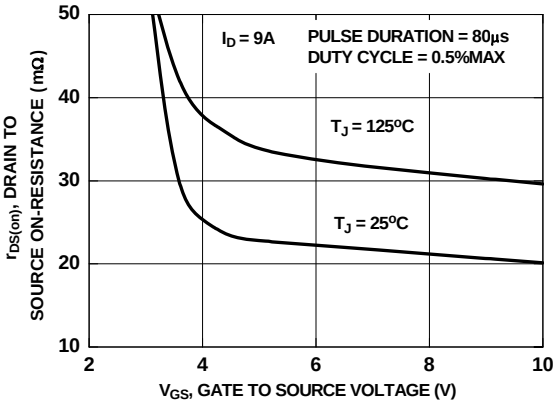


Figure 4. On-Resistance vs Gate to Source Voltage

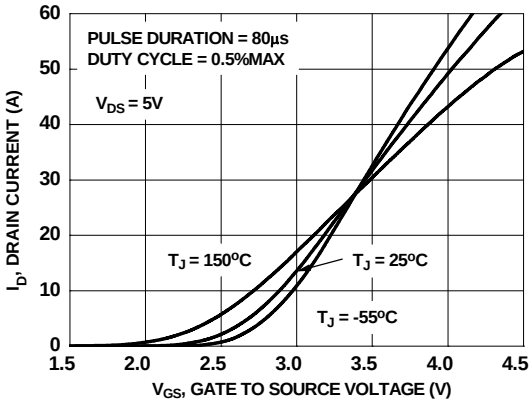


Figure 5. Transfer Characteristics

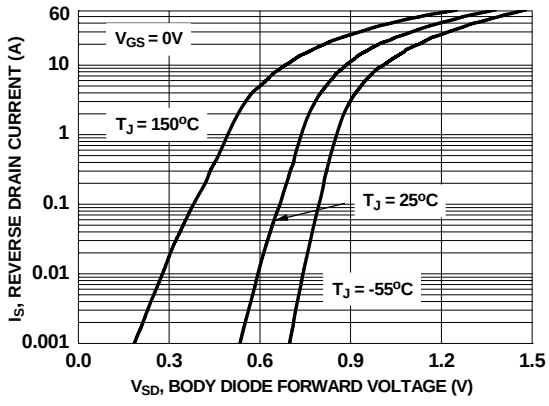


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q1 N-Channel) T_J = 25°C unless otherwise noted

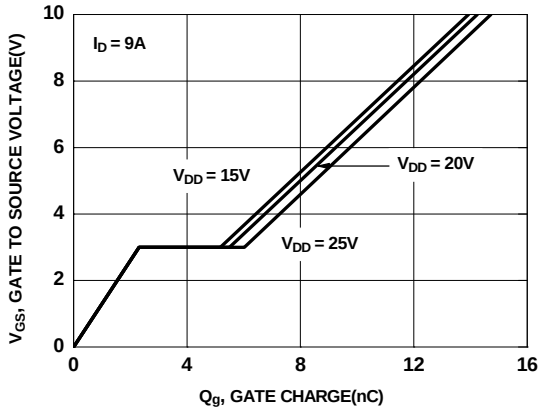


Figure 7. Gate Charge Characteristics

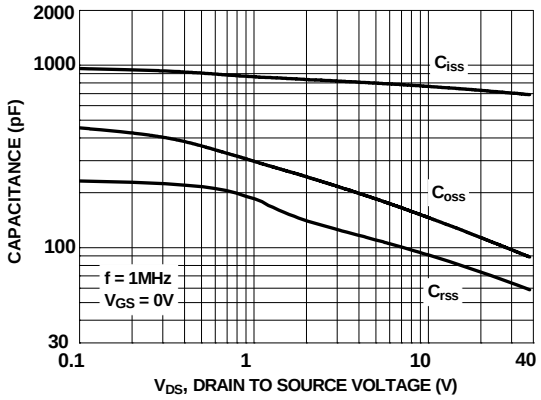


Figure 8. Capacitance vs Drain to Source Voltage

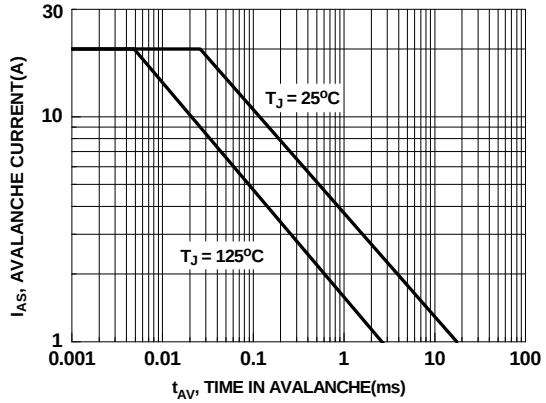


Figure 9. Unclamped Inductive Switching Capability

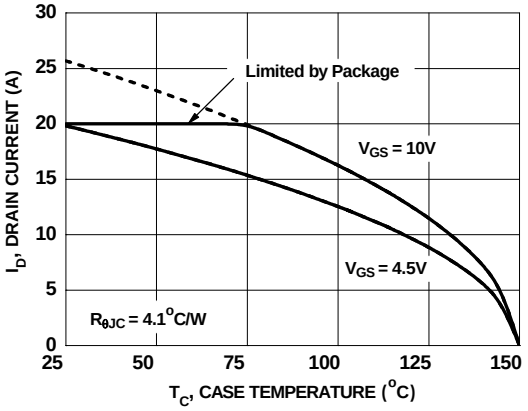


Figure 10. Maximum Continuous Drain Current vs Case Temperature

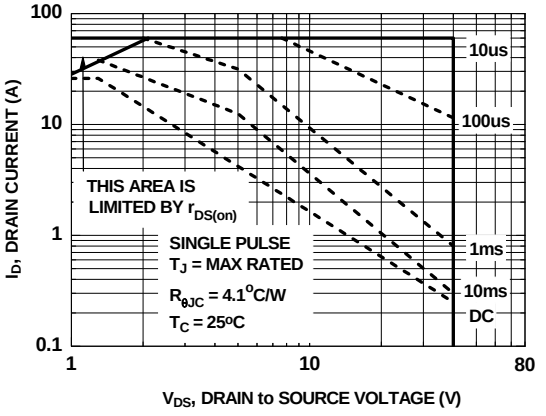


Figure 11. Forward Bias Safe Operating Area

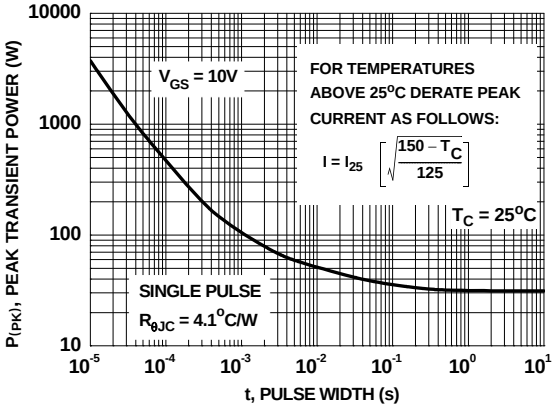


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q1 N-Channel) T_J = 25°C unless otherwise noted

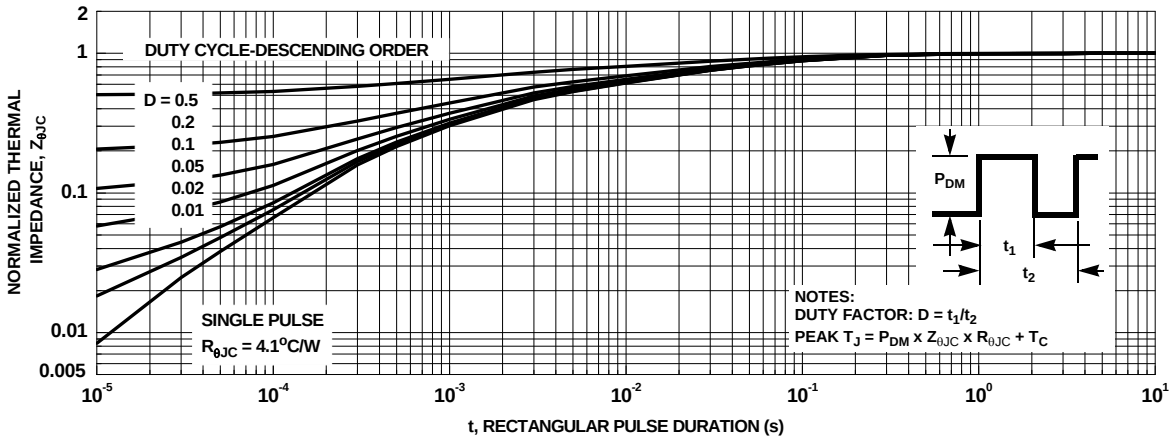


Figure 13. Transient Thermal Response Curve

Typical Characteristics (Q2 P-Channel) T_J = 25°C unless otherwise noted

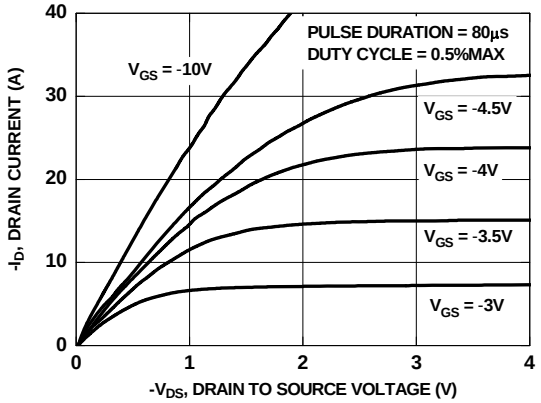


Figure 14. On- Region Characteristics

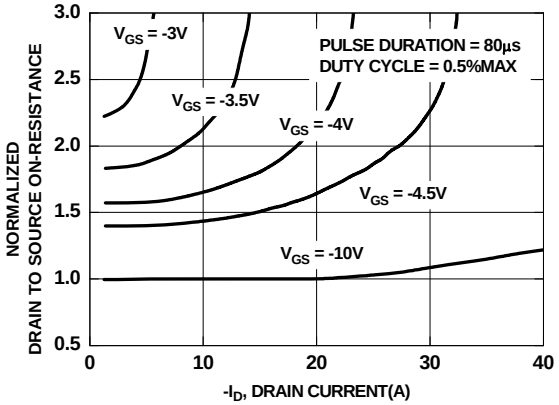


Figure 15. Normalized on-Resistance vs Drain Current and Gate Voltage

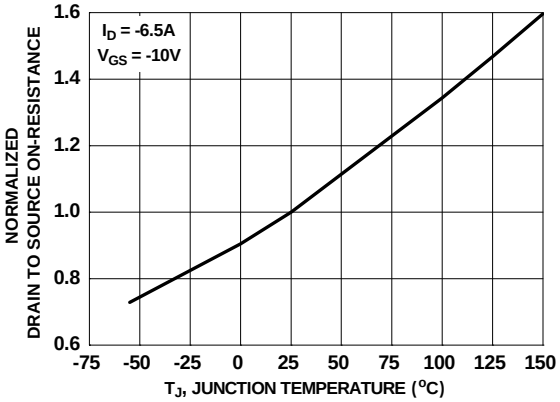


Figure 16. Normalized On-Resistance vs Junction Temperature

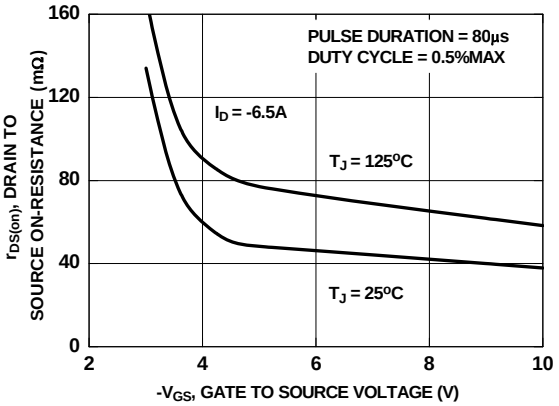


Figure 17. On-Resistance vs Gate to Source Voltage

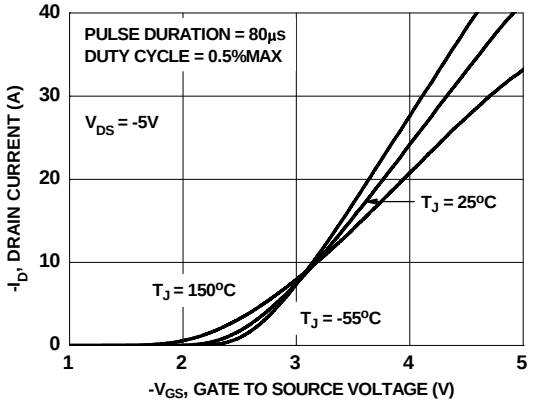


Figure 18. Transfer Characteristics

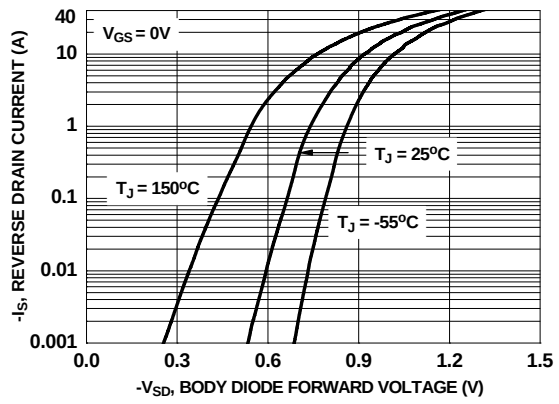


Figure 19. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q2 P-Channel) T_J = 25°C unless otherwise noted

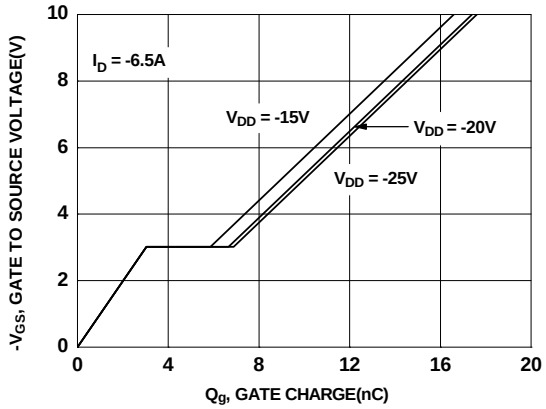


Figure 20. Gate Charge Characteristics

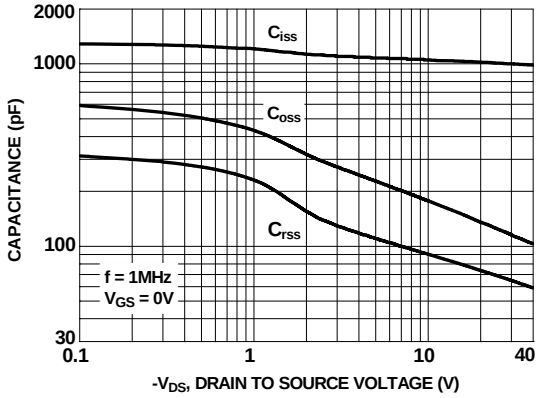


Figure 21. Capacitance vs Drain to Source Voltage

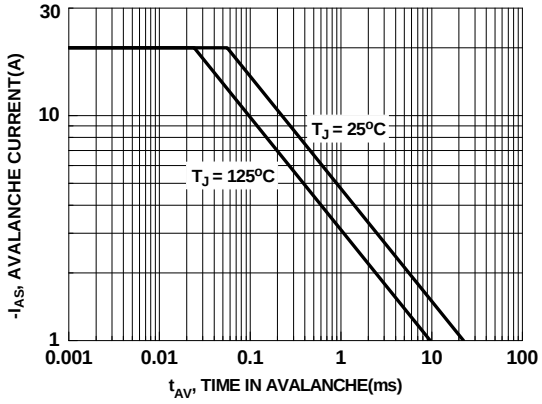


Figure 22. Unclamped Inductive Switching Capability

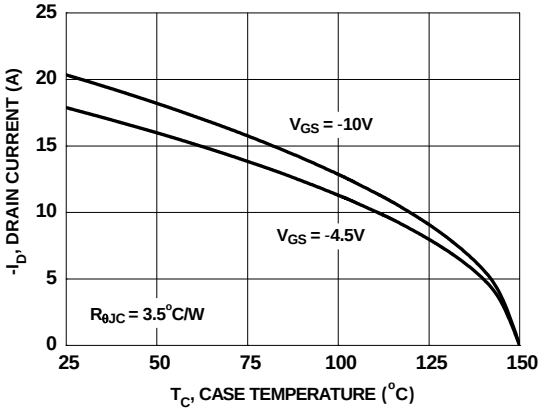


Figure 23. Maximum Continuous Drain Current vs Case Temperature

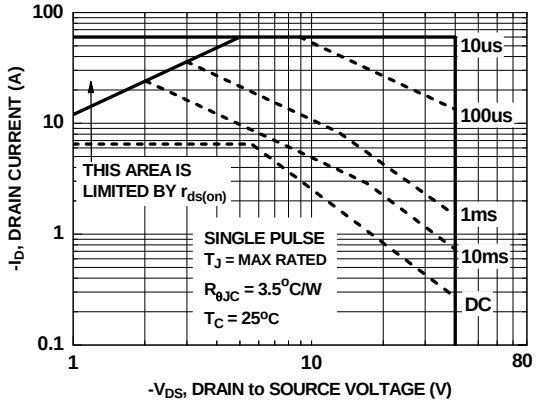


Figure 24. Forward Bias Safe Operating Area

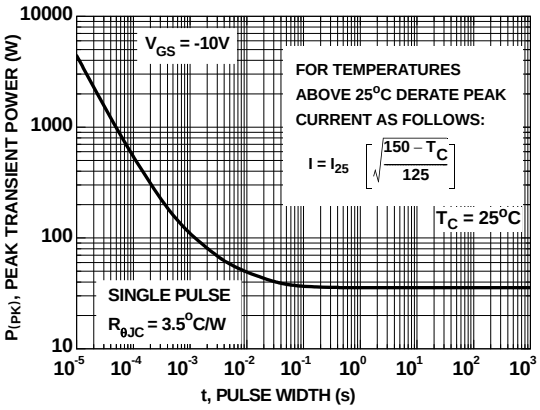


Figure 25. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q2 P-Channel) T_J = 25°C unless otherwise noted

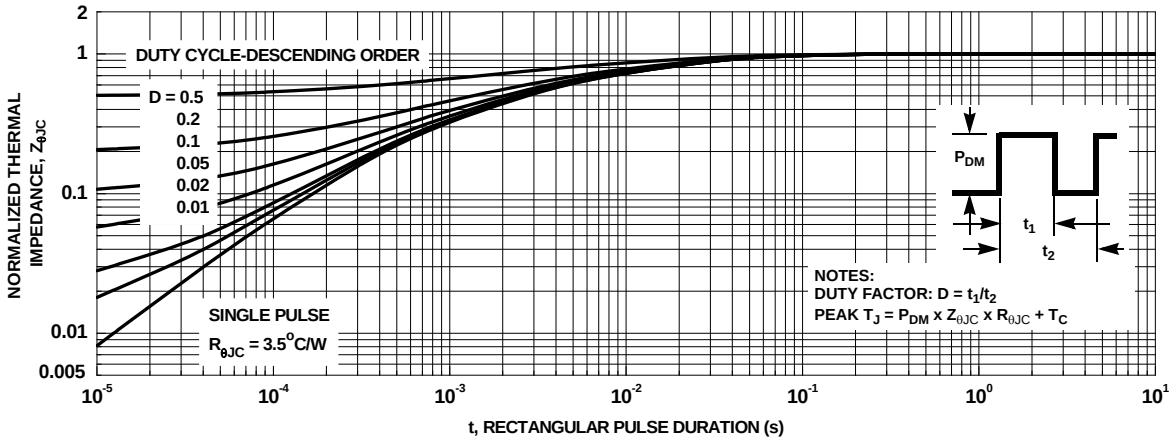
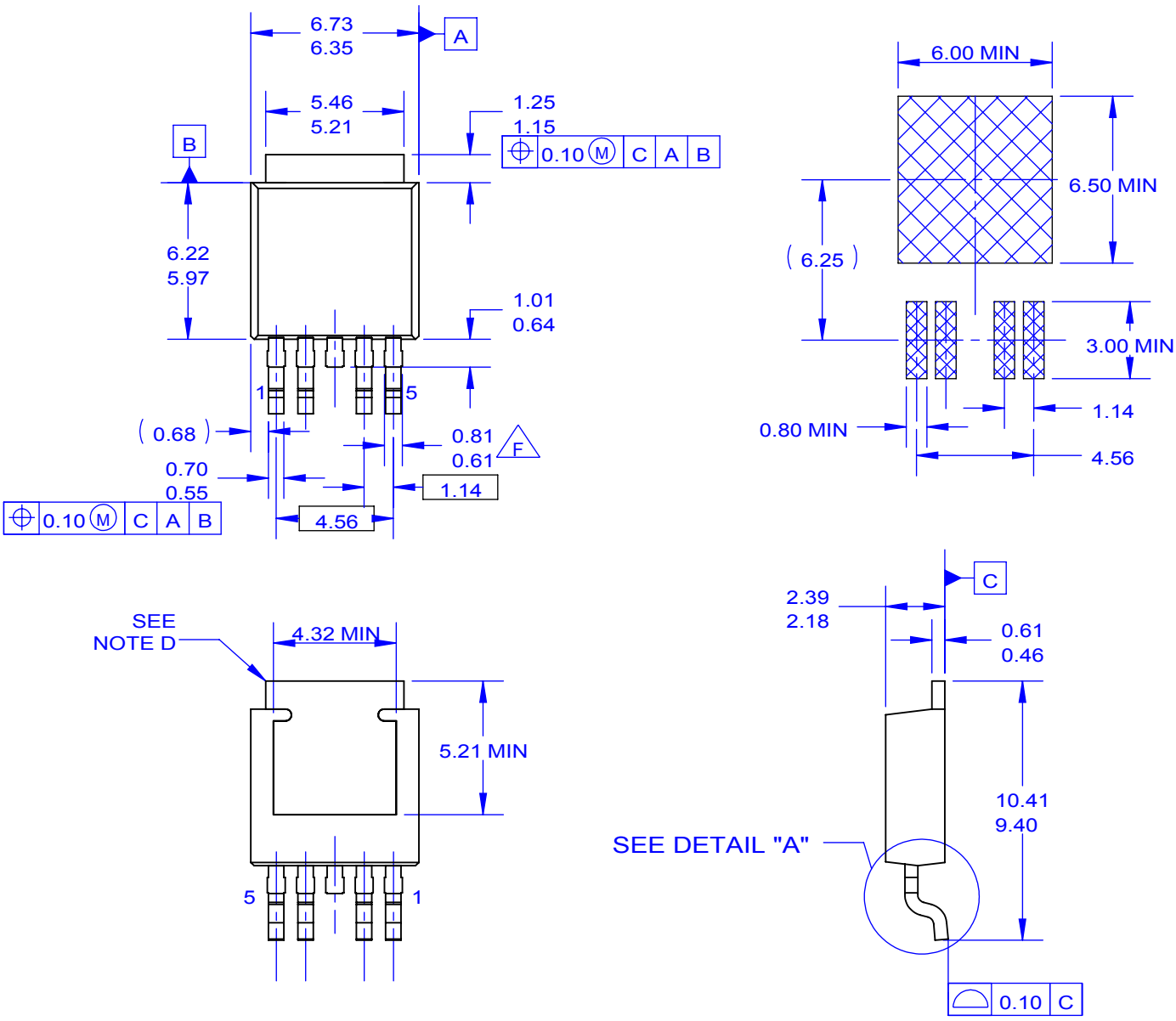


Figure 26. Transient Thermal Response Curve



DETAIL A
SCALE 2:1

NOTES: UNLESS OTHERWISE SPECIFED

A. THIS PACKAGE CONFORMS TO JEDEC, TO252 VARIATION AD.
B. ALL DIMENSIONS ARE IN MILLIMETERS.
C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS
D. HEATSINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION.
E. DIMENSIONS AND TOLERANCES AS PER ASME Y14.5-2009.
F EXCEPTION TO TO-252 STANDARD.
G. FILE NAME: TO252B05REV3
H. FAIRCHILDSEMICONDUCTOR

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FACT®
FastvCore™
FETBench™
FPS™
F-PFS™
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Green FPS™ e-Series™
G*max*™
GTO™
IntelliMAX™
ISOPLANAR™
Making Small Speakers Sound Louder and Better™
MegaBuck™
MICROCOUPLER™
MicroFET™
MicroPak™
MicroPak2™
MillerDrive™
MotionMax™
MotionGrid®
MTi®
MTx®
MVN®
mWSaver®
OptoHiT™
OPTOLOGIC®
OPTOPLANAR®
®
Power Supply WebDesigner™
PowerTrench®
PowerXS™
Programmable Active Droop™
QFET®
QS™
Quiet Series™
RapidConfigure™
™
Saving our world, 1mW/W/kW at a time™
SignalWise™
SmartMax™
SMART START™
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Definition of Terms

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